

**Notice of References Cited**

Application/Control No.

09/802,482

Applicant(s)/Patent Under  
Reexamination  
WEGERICH ET AL.

Examiner

Paul L Kim

Art Unit

2857

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6418431 B1	07-2002	Mahajan et al	707/4
	C	US-6202038 B1	03-2001	Wegerich et al	702/183
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Keller, May 1994, "Three Neural Network Based, Sensor Systems for Environmental Monitoring", p377-382
	V	Rajan et al, Jan. 1998; "Machine Learning Algorithm for Fault Diagnosis in Analog Circuits", p1874-1879
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.